

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Koyama, et al.

Art Unit: 2871

Serial No.: 09/757,778

Examiner: Tai Duong

Filed

: January 9, 2001

Title

: ACTIVE MATRIX LIQUID CRYSTAL DISPLAY AND METHOD OF

**FABRICATING SAME** 

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants submit the references listed on the attached form PTO-1449. Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
AL	Japan 6-244103 – English Abstract: DIALOG(R) File 352: Derwent
	WPI (2004); Accession No. 009997897 and family to U.S. Patent No.
	5,608,232 (Desig. ID "AA")
AM	Japan 6-244104 – English Abstract: DIALOG(R) File 345:
	Inpadoc/Fam. & Legal Stat (2003); Accession No. 11970014 and
	family to U.S. Patent No. 5,879,977 (Desig. ID "AB")

This statement is being filed before the receipt of a first Office action on the merits after filing of a Request for Continued Examination. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 8, 2004

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office		Application No. 09/757,778
1		Applicant Koyama, et al.	R APR 0 8 2004
(Use several st	neets if necessary)	Filing Date January 9, 2001	Group Art Units

			U.S. Pate	ent Documents			ADEMAD
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,608,232	03/04/1997	Yamazaki et al.			06/05/1995
	AB	5,879,977	03/09/1999	Zhang et al.			04/23/1996
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	AD						
	AE			·			
	AF		-				
	AG						
	AH						-
	AI						
	AJ						
	AK						

	Foreig	n Patent Do	cuments or F	Published Foreign	Patent A	Application	ns	
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Trans	lation No
	AL	6-244103	09/02/1994	JAPAN			ABS	
	AM	6-244104	09/02/1994	JAPAN			ABS	
	AN							
	AO							
	AP							

	Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.				
Initial	ID_	Document			
	AQ				
	AR				
_	AS				
	AT				

Examiner Signature	Date Considered
	Bate Generalica
EXAMINER: Initials citation considered. Draw line through citation if no	of the conformance and not considered. Include copy of this form with
next communication to applicant	